

<b>Notice of References Cited</b>	Application/Control No. 10/605,537	Applicant(s)/Patent Under Reexamination JEON ET AL.	
	Examiner William H. Beisner	Art Unit 1744	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,296,375	03-1994	Kricka et al.	435/2
*	B	US-5,744,366	04-1998	Kricka et al.	436/63
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	S					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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